

## PowerMOS transistor

### GENERAL DESCRIPTION

N-channel enhancement mode field-effect power transistor in a plastic envelope.

The device is intended for use in Switched Mode Power Supplies (SMPS), motor control, welding, DC/DC and AC/DC converters, and in general purpose switching applications.

### QUICK REFERENCE DATA

SYMBOL	PARAMETER	BUK437	MAX.	MAX.	UNIT
$V_{DS}$	Drain-source voltage		-400A	-400B	V
$I_D$	Drain current (DC)	400	400	400	A
$P_{tot}$	Total power dissipation	14	12	12	W
$R_{DS(ON)}$	Drain-source on-state resistance	180	180	180	$\Omega$
		0.4	0.5	0.5	

### MECHANICAL DATA

Dimensions in mm

Net Mass: 5 g

Pinning:

1 = Gate

2 = Drain

3 = Source

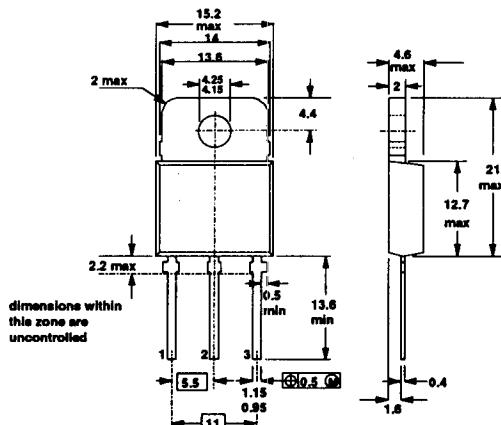
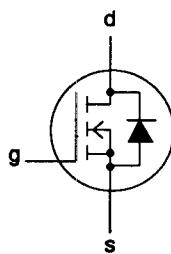


Fig.1 SOT-93; drain connected to mounting base.

blue binder, tab 4

#### Notes

1. Observe the general handling precautions for electrostatic-discharge sensitive devices (ESDs) to prevent damage to MOS gate oxide.
2. Accessories supplied on request: refer to Mounting instructions for SOT93 envelope.

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**PHILIPS**

**RATINGS**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.		UNIT
$V_{DS}$	Drain-source voltage	$R_{GS} = 20 \text{ k}\Omega$	-	400		V
$V_{DGS}$	Drain-gate voltage		-	400		V
$\pm V_{GS}$	Gate-source voltage		-	30		V
$I_D$	Drain current (DC)	$T_{mb} = 25^\circ\text{C}$	-	-400A	-400B	A
$I_D$	Drain current (DC)		-	14	12	A
$I_{DM}$	Drain current (pulse peak value)		-	8.8	7.6	A
$P_{tot}$	Total power dissipation	$T_{mb} = 25^\circ\text{C}$	-	56	48	A
$T_{stg}$	Storage temperature		-	180		W
$T_J$	Junction Temperature		-55	150	150	°C

**THERMAL RESISTANCES**

From junction to mounting base	$R_{th,j-mb} = 0.69 \text{ K/W}$
From junction to ambient	$R_{th,j-a} = 45 \text{ K/W}$

**STATIC CHARACTERISTICS** $T_{mb} = 25^\circ\text{C}$  unless otherwise specified

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
$V_{(BR)DSS}$	Drain-source breakdown voltage	$V_{GS} = 0 \text{ V}; I_D = 0.25 \text{ mA}$	400	-	-	V
$V_{GS(TO)}$	Gate threshold voltage	$V_{DS} = V_{GS}; I_D = 1 \text{ mA}$	2.1	3.0	4.0	V
$I_{DSS}$	Zero gate voltage drain current	$V_{DS} = 400 \text{ V}; V_{GS} = 0 \text{ V}; T_J = 25^\circ\text{C}$	-	2	20	$\mu\text{A}$
$I_{DSS}$	Zero gate voltage drain current	$V_{DS} = 400 \text{ V}; V_{GS} = 0 \text{ V}; T_J = 125^\circ\text{C}$	-	0.1	1.0	mA
$I_{GSS}$	Gate source leakage current	$V_{GS} = \pm 30 \text{ V}; V_{DS} = 0 \text{ V}$	-	10	100	nA
$R_{DS(ON)}$	Drain-source on-state resistance	$V_{GS} = 10 \text{ V}; I_D = 6.5 \text{ A}$ BUK437-400A BUK437-400B	-	0.35	0.4	$\Omega$

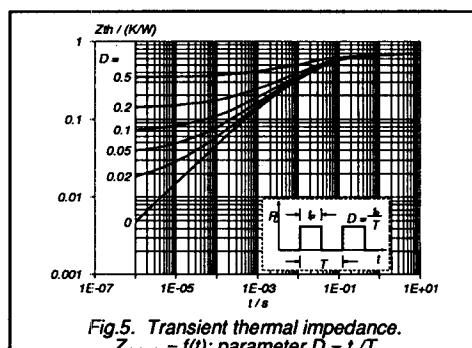
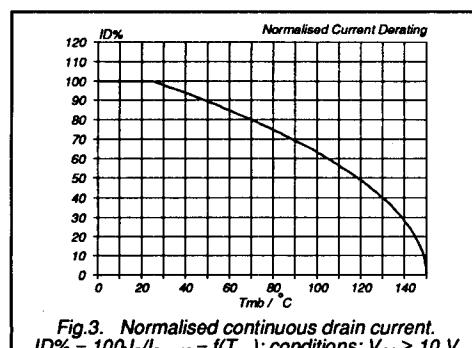
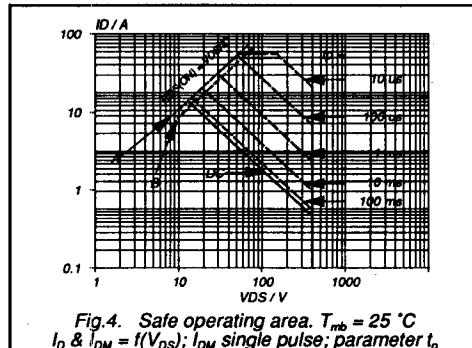
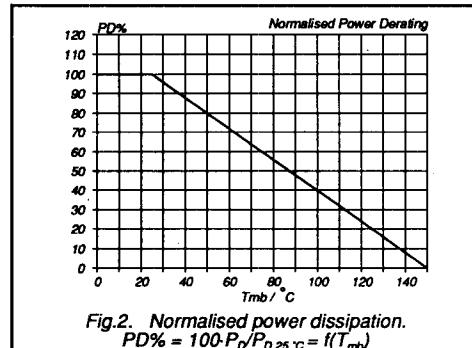
**DYNAMIC CHARACTERISTICS** $T_{mb} = 25^\circ\text{C}$  unless otherwise specified

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
$g_{fs}$	Forward transconductance	$V_{DS} = 25 \text{ V}; I_D = 6.5 \text{ A}$	5.0	8.0	-	S
$C_{iss}$	Input capacitance	$V_{GS} = 0 \text{ V}; V_{DS} = 25 \text{ V}; f = 1 \text{ MHz}$	-	1500	1800	pF
$C_{oss}$	Output capacitance		-	170	270	pF
$C_{rss}$	Feedback capacitance		-	70	120	pF
$t_{d(on)}$	Turn-on delay time	$V_{DD} = 30 \text{ V}; I_D = 2.8 \text{ A};$	-	20	40	ns
$t_r$	Turn-on rise time	$V_{GS} = 10 \text{ V}; R_{GS} = 50 \Omega;$	-	60	90	ns
$t_{d(off)}$	Turn-off delay time	$R_{gen} = 50 \Omega$	-	200	250	ns
$t_f$	Turn-off fall time		-	75	90	ns
$L_d$	Internal drain inductance	Measured from contact screw on tab to centre of die	-	5	-	nH
$L_d$	Internal drain inductance	Measured from drain lead 6 mm from package to centre of die	-	5	-	nH
$L_s$	Internal source inductance	Measured from source lead 6 mm from package to source bond pad	-	12.5	-	nH

## REVERSE DIODE RATINGS AND CHARACTERISTICS

 $T_{mb} = 25^\circ\text{C}$  unless otherwise specified

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
$I_{DR}$	Continuous reverse drain current	-	-	-	14	A
$I_{DRM}$	Pulsed reverse drain current	-	-	-	56	A
$V_{SD}$	Diode forward voltage	$I_F = 14 \text{ A}; V_{GS} = 0 \text{ V}$	-	1.1	1.4	V
$t_{rr}$	Reverse recovery time	$I_F = 14 \text{ A}; -dI_F/dt = 100 \text{ A}/\mu\text{s}$	-	500	-	ns
$Q_{rr}$	Reverse recovery charge	$V_{GS} = 0 \text{ V}; V_R = 100 \text{ V}$	-	6.0	-	$\mu\text{C}$



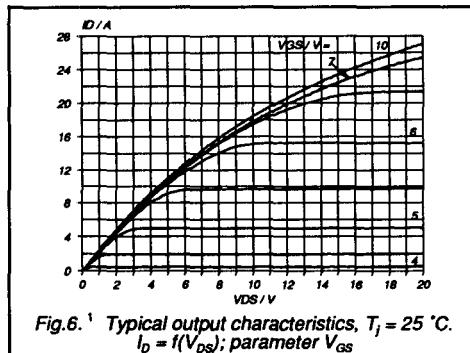


Fig.6.  $^1$  Typical output characteristics,  $T_j = 25^\circ\text{C}$ .  
 $I_D = f(V_{DS})$ ; parameter  $V_{GS}$

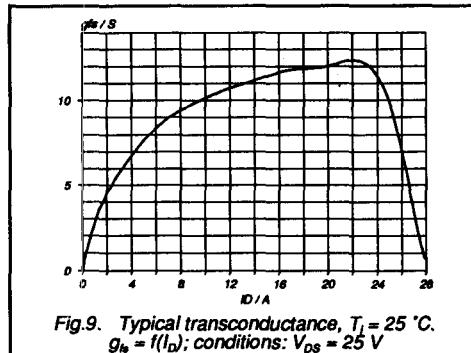


Fig.9. Typical transconductance,  $T_j = 25^\circ\text{C}$ .  
 $g_{DS} = f(I_D)$ ; conditions:  $V_{DS} = 25\text{ V}$

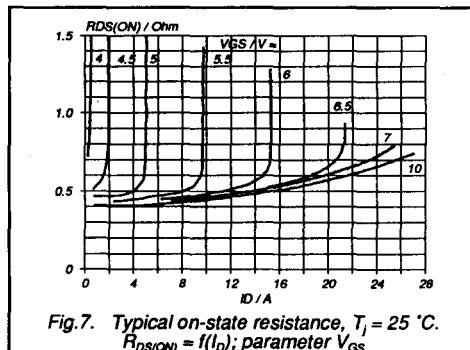


Fig.7. Typical on-state resistance,  $T_j = 25^\circ\text{C}$ .  
 $R_{DS(ON)} = f(I_D)$ ; parameter  $V_{GS}$

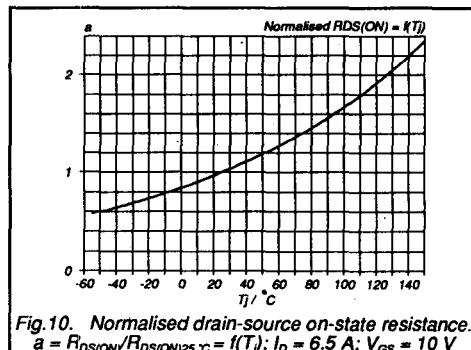


Fig.10. Normalised drain-source on-state resistance.  
 $a = R_{DS(ON)}/R_{DS(ON)25^\circ\text{C}} = f(T_j)$ ;  $I_D = 6.5\text{ A}$ ;  $V_{GS} = 10\text{ V}$

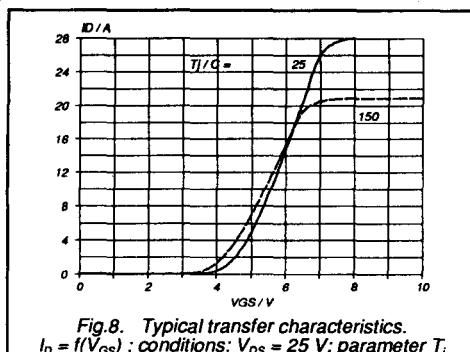


Fig.8. Typical transfer characteristics.  
 $I_D = f(V_{GS})$ ; conditions:  $V_{DS} = 25\text{ V}$ ; parameter  $T_j$

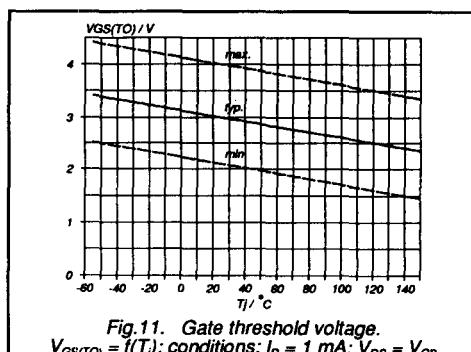


Fig.11. Gate threshold voltage.  
 $V_{GS(To)} = f(T_j)$ ; conditions:  $I_D = 1\text{ mA}$ ;  $V_{DS} = V_{GS}$

